

<b>Notice of References Cited</b>		Application/Control No. 10/830,049	Applicant(s)/Patent Under Reexamination OHNISHI ET AL.	
		Examiner John B. Nguyen	Art Unit 2819	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,774,718 B2	08-2004	Ichitsubo et al.	330/129
	B	US-6,885,246 B2	04-2005	Tsutsui et al.	330/285
	C	US-6,714,071 B1	03-2004	Page, Trevor A.	330/136
	D	US-6,775,525 B1	08-2004	Tanoue et al.	455/127.3
	E	US-6,759,906 B2	07-2004	Matsunaga et al.	330/285
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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